



中国认可  
国际互认  
检测  
TESTING  
CNAS L4062



# TEST REPORT

**Reference No.** : WTX23X05108883W003  
**Manufacturer** : Mid Ocean Brands B.V.  
**Address** : 7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong  
**Factory** : 106613  
**Product Name** : Optical mouse in RABS bamboo  
**Model No.** : MO2085  
**Standards** : EN 55032:2015+A1:2020; EN 55035:2017+A11:2020  
EN IEC 61000-3-2:2019+A1:2021; EN 61000-3-3:2013+A2:2021  
ETSI EN 301 489-1 V2.2.3 (2019-11)  
Draft ETSI EN 301 489-3 V2.3.0 (2022-07)  
**Date of Receipt sample** : 2023-05-19  
**Date of Test** : 2023-05-19 to 2023-06-02  
**Date of Issue** : 2023-06-02  
**Test Report Form No.** : WTX\_ESI EN 301 489\_1\_2019W  
**Test Result** : Pass

**Remarks:**

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

**Prepared By:**

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## Report version

Version No.	Date of issue	Description
Rev.00	2023-06-02	Original
/	/	/

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## 1. GENERAL INFORMATION

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### 1.1 Product Description for Equipment Under Test (EUT)

<b>General Description of EUT</b>	
Product Name:	Optical mouse in RABS bamboo
Trade Name:	/
Model No.:	MO2085
Adding Model(s):	/
Rated Voltage:	Battery:DC1.5V"AA"
Battery Capacity:	/
Power Adaptor Model:	V05
Software Version:	XD_MS_8S_HS06_V05

*Note: The test data is gathered from a production sample, provided by the manufacturer.*

<b>Technical Characteristics of EUT</b>	
<b>2.4GHz</b>	
Frequency Range:	2402-2480MHz
RF Output Power:	-9.51dBm (EIRP)
Type of Modulation:	GFSK
Type of Antenna:	PCB Antenna
Antenna Gain:	-4.62dBi

*Note: The Antenna Gain is provided by the customer and can affect the validity of results.*



## 1.2 Test Standards

The tests were performed according to following standards:

**EN 55032:2015+A1:2020**: Electromagnetic compatibility of multimedia equipment - Emission requirements

**EN 55035:2017+A11:2020**: Electromagnetic compatibility of multimedia equipment - Immunity requirements.

**EN IEC 61000-3-2:2019+A1:2021**: Electromagnetic compatibility (EMC) -- Part 3-2: Limits - Limits for harmonic current emissions (equipment input current up to and including 16 A per phase).

**EN 61000-3-3:2013+A2:2021**: Electromagnetic compatibility (EMC) -- Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current <= 16 A per phase and not subject to conditional connection.

**ETSI EN 301 489-1 V2.2.3 (2019-11)**: Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard for Electromagnetic Compatibility.

**Draft ETSI EN 301 489-3 V2.3.0 (2022-07)**: Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 3: Specific conditions for Short-Range Devices (SRD) operating on frequencies between 9 kHz and 246 GHz; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU.

**Maintenance of compliance** is the responsibility of the manufacturer. Any modification of the product maybe which result in lowering the emission/immunity should be checked to ensure compliance has been maintained.

## 1.3 Test Methodology

All measurements contained in this report were conducted with the standard ETSI EN 301489-1, Electromagnetic compatibility and Radio spectrum Matters (ERM); Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements.



## 1.4 Test Facility

### Address of the test laboratory

Laboratory: Waltek Testing Group (Shenzhen) Co., Ltd.

Address: 1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd Road, Block 70 Bao'an District, Shenzhen, Guangdong, China

### FCC – Registration No.: 125990

Waltek Testing Group (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. The Designation Number is CN5010, and Test Firm Registration Number is 125990.

### Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Waltek Testing Group (Shenzhen) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

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## 1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission/immunity level. The test modes were adapted according to the operation manual for use, more detailed description as follows:

<b>Test Mode List</b>			
Test Mode	Description	Remark	
TM1	Normal working	The dongle connected to the notebook ; and normal working	
TM2	2.4GHz	TR, CR, TT, CT for EMS testing	

<b>Special Cable List and Details</b>			
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite
/	/	/	/

<b>Auxiliary Equipment List and Details</b>			
Description	Manufacturer	Model	Serial Number
Computer	/	L13 Yoga	/
USB dongle	/	MO2085	/



## 1.6 Performance Criteria for EMS

- EN 301 489-3, The performance criteria are:

In the table below:

- performance criterion A applies for immunity tests with phenomena of a continuous nature;
- performance criterion B applies for immunity tests with phenomena of a transient nature.

NOTE: Whether a phenomenon is considered transient, continuous or otherwise is indicated in the test procedures for the phenomenon in ETSI EN 301 489-1 [1], clause 9.

Table 2: Performance Requirements

Criterion	During test	After test
A	Operate as intended No loss of function No unintentional responses	Operate as intended No loss of function No degradation of performance No loss of stored data or user programmable functions
B	May show loss of function No unintentional responses	Operate as intended Lost function(s) shall be self-recoverable No degradation of performance No loss of stored data or user programmable functions

Where "operate as intended" or "no loss of function" is specified, the EUT shall demonstrate correct functioning as described in ETSI EN 301 489-3 [1], clause 5.

Where the EUT has more than one mode of operation (see clause 4.5.2), an unplanned transition from one mode to another is considered as an unintentional response. The EUT shall be tested in sufficient modes to confirm there are no such unintentional responses.



➤ **EN 55035, The performance criteria are:**

- A. The apparatus shall continue to operate as intended during and after the test. The manufacturer specifies some minimum performance level. The performance level may be specified by the manufacturer as a permissible loss of performance.
- B. The apparatus shall continue to operate as intended after the test. This indicates that the EUT does not need to function at normal performance levels during the test, but must recover. Again some minimal performance is defined by the manufacturer. No change in operating state or loss or data is permitted.
- C. Temporary loss of function is allowed. Operation of the EUT may stop as long as it is either automatically reset or can be manually restored by operation of the controls.

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## 1.7 Measurement Uncertainty

<b>Measurement uncertainty</b>	
<b>Parameter</b>	<b>Uncertainty</b>
Uncertainty for Radiated Emission in 3m chamber	@ 30-200MHz $\pm 4.52\text{dB}$ @ 0.2-1GHz $\pm 5.56\text{dB}$ @ 1-6GHz $\pm 3.84\text{dB}$ @ 6-18GHz $\pm 3.92\text{dB}$
Uncertainty for Conducted Emission	@ 9-150kHz $\pm 3.74\text{dB}$ @ 0.15-30MHz $\pm 3.34\text{dB}$
Uncertainty for Harmonic test	3.26%
Uncertainty for Flicker test	4.76%
Uncertainty for RS test	21%, k=2
Uncertainty for CS test	29%, k=2
Uncertainty for ESD test	The immunity measurement system uncertainty is within standard requirement and is based on a standard uncertainty multiplied by a coverage factor k=2, providing a level of confidence of approximately 95%.
Uncertainty for EFT test	
Uncertainty for Surges test	
Uncertainty for Voltage Dips, Voltage Variations and Short Interruptions Test	
Uncertainty for PFMF test	



## 1.8 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal Date	Due Date
<input checked="" type="checkbox"/> Chamber A: Below 1GHz					
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2023-02-25	2024-02-24
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2023-02-25	2024-02-24
Amplifier	HP	8447F	2805A03475	2023-02-25	2024-02-24
Loop Antenna	Schwarz beck	FMZB 1516	9773	2021-03-20	2024-03-19
Trilog Broadband Antenna	Schwarz beck	VULB9163	9163-333	2023-03-20	2026-03-19
<input checked="" type="checkbox"/> Chamber A: Above 1GHz					
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2023-02-25	2024-02-24
Spectrum Analyzer	Rohde & Schwarz	FSP40	100612	2023-02-25	2024-02-24
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2023-02-25	2024-02-24
Amplifier	C&D	PAP-1G18	14918	2023-02-25	2024-02-24
Horn Antenna	ETS	3117	00086197	2021-03-19	2024-03-18
DRG Horn Antenna	A.H. SYSTEMS	SAS-574	571	2021-03-19	2024-03-18
Pre-amplifier	Schwarz beck	BBV 9721	9721-031	2023-02-25	2024-02-24
<input type="checkbox"/> Chamber B:Below 1GHz					
Trilog Broadband Antenna	Schwarz beck	VULB9163(B)	9163-635	2021-04-09	2024-04-08
Amplifier	Agilent	8447D	2944A10179	2023-02-25	2024-02-24
EMI Test Receiver	Rohde & Schwarz	ESPI	101391	2023-02-25	2024-02-24
<input type="checkbox"/> Chamber C:Below 1GHz					
EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2023-02-25	2024-02-24
Trilog Broadband Antenna	Schwarz beck	VULB 9168	1194	2021-05-28	2024-05-27
Amplifier	HP	8447F	2944A03869	2023-02-25	2024-02-24
<input type="checkbox"/> Chamber C: Above 1GHz					
EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2023-02-25	2024-02-24
Horn Antenna	POAM	RTF-11A	LP228060221	2023-03-10	2026-03-09
Amplifier	Tonscend	TAP01018050	AP22E806235	2023-02-25	2024-02-24
<input checked="" type="checkbox"/> Conducted Room 1#					
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2023-02-25	2024-02-24
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2023-02-25	2024-02-24
AC LISN	Schwarz beck	NSLK8126	8126-224	2023-02-25	2024-02-24
8-WIRE LISN	Schwarz beck	8158	CAT3-8158-0059	2023-02-25	2024-02-24
8-WIRE LISN	Schwarz beck	8158	CAT5-8158-0117	2023-02-25	2024-02-24
<input type="checkbox"/> Conducted Room 2#					
EMI Test Receiver	Rohde & Schwarz	ESPI	10129	2023-02-25	2024-02-24
LISN	Rohde & Schwarz	ENV 216	100097	2023-02-25	2024-02-24



EMF					
VDH Test Head	AFJ	VDH 30	SC022Z	2023-02-25	2024-02-24
3 Loop Antenna					
Loop Antenna	ZHINAN	ZN30401	19037	2023-02-25	2025-02-24
Clamp					
Clamp	Luthi	MDS21	3809	2023-02-27	2024-02-26
PFMF					
PMF Generator	LIONCEL	PMF-801C-C	0171101	2023-02-25	2024-02-24
PMF Antenna	LIONCEL	PMF-801C-A	0180302	2023-02-25	2024-02-24
Instantaneous PMF Generator Module	LIONCEL	PMF-801C-T	0171001	2023-02-25	2024-02-24
H/F					
Digital Power Analyzer	California Instrument	CTS	72831	2023-02-25	2024-02-24
Power Source	California Instrument	5001IX-CTS-400	25965	2023-02-25	2024-02-24
ESD					
ESD Generator	LIONCEL	ESD-203B	0170901	2023-03-14	2024-03-13
EFT/SURGE/DIPS					
Transient 2000	EMC PARTNER	TRA2000	863	2023-02-25	2024-02-24
Couple Clamp	EMC PARTNER	CN-EFT1000	513	2023-02-25	2024-02-24
CS					
CONDUCTED IMMUNITY TEST SYSTEM	FRANKONIA	CIT-10/75	126B1247/2013	2023-02-25	2024-02-24
Attenuator	EMTEST	MA-5100/6BF2	1009	2023-02-25	2024-02-24
CDN	Luthi	L-801M2/M3	2665	2023-02-25	2024-02-24
CDN	LIONCEL	CDN-T8	0210401	2023-02-25	2024-02-24
EM Clamp	TESEQ	KEMZ801A	45028	2023-02-25	2024-02-24
RS					
Signal Generator	HP	8688B	3438A00604	2023-02-25	2024-02-24
Power Meter	KEITHLEY	3500	1162591	2023-02-25	2024-02-24
Power Meter	KEITHLEY	3500	1121428	2023-02-25	2024-02-24
RF Power Amplifier	MicoTop	MPA-80-1000-250	MPA1906239	2023-02-25	2024-02-24
RF Power Amplifier	MicoTop	MPA-80-6000-100	MPA1906238	2023-02-25	2024-02-24
Antenna	SCHWARZBECK	STLP 9129	9129 114	N/A	N/A
Power Meter	Agilent	E4419B	GB42420578	2023-02-25	2024-02-24



Software List			
Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)*	Farad	EZ-EMC	RA-03A1
EMI Test Software (Conducted Emission)*	Farad	EZ-EMC	RA-03A1

\*Remark: indicates software version used in the compliance certification testing.

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## 2. SUMMARY OF TEST RESULTS

Standards	Reference	Description of Test Item	Result
ETSI EN 301 489-1	8.2	Radiated Emissions	Pass
	8.3	Conducted Emissions for DC Power Port	N/A
	8.4	Conducted Emissions for AC Power Port	N/A
	8.5	Harmonic Current Emissions	N/A
	8.6	Voltage Fluctuations and Flicker	N/A
	8.7	Telecommunication Ports	N/A
	9.2	Radio Frequency Electromagnetic Field	Pass
	9.3	Electrostatic Discharge	Pass
	9.4	Fast Transients, Common Mode	N/A
	9.5	Radio Frequency, Common Mode	N/A
	9.6	Transient and Surges in the Vehicular Environment	N/A
	9.7	Voltage Dips and Interruptions	N/A
	9.8	Surges	N/A

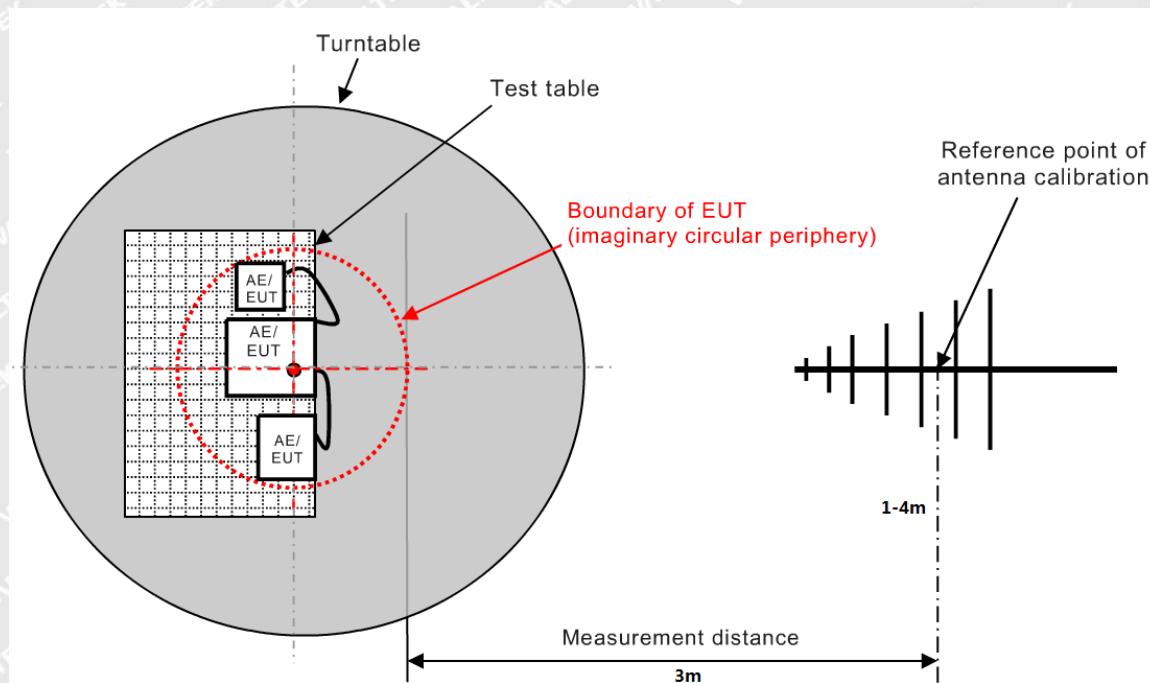
Pass: The EUT complies with the essential requirements in the standard.  
Fail: The EUT does not comply with the essential requirements in the standard.  
N/A: Not applicable.



### 3. Radiated Emissions

#### 3.2 Test Procedure

Test is conducting under the description of EN55032 Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement.



#### 3.2 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The “Margin” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of  $-6\text{dB}\mu\text{V}$  means the emission is  $6\text{dB}\mu\text{V}$  below the maximum limit for Class B device. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{EN 301489 Class B Limit}$$



### 3.3 Environmental Conditions

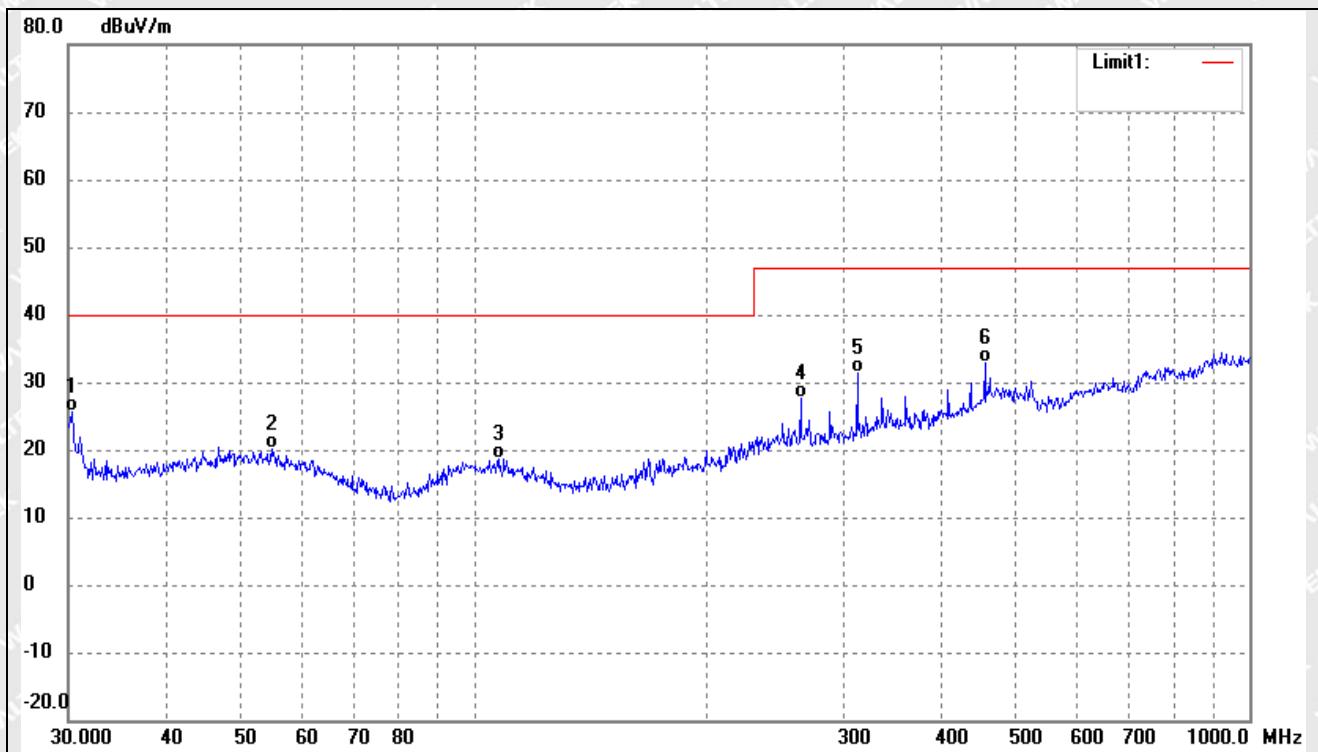
Temperature:	22° C
Relative Humidity:	54%
ATM Pressure:	1011 mbar

### 3.4 Summary of Test Results/Plots

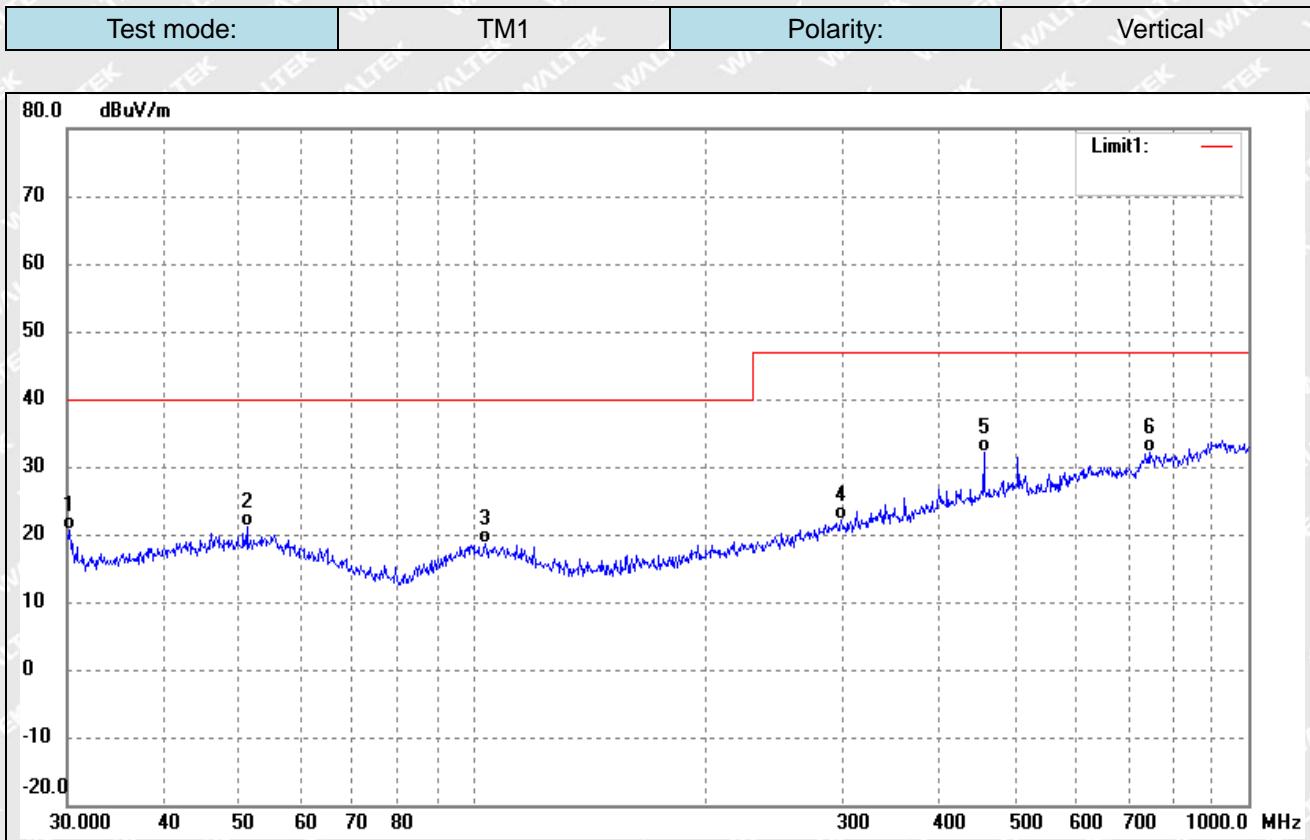
Note: Only show the worst case in the test report

➤ 30MHz to 1GHz

Test mode:	TM1	Polarity:	Horizontal
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No.	Frequency (MHz)	Reading (dBuV/m)	Correct dB/m	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ( )	Height (cm)	Remark
1	30.3173	36.33	-10.76	25.57	40.00	-14.43	-	-	QP
2	54.8348	27.66	-7.61	20.05	40.00	-19.95	-	-	QP
3	107.5101	27.28	-8.54	18.74	40.00	-21.26	-	-	QP
4	263.8190	33.97	-6.24	27.73	47.00	-19.27	-	-	QP
5	312.1794	36.00	-4.53	31.47	47.00	-15.53	-	-	QP
6	455.9058	34.99	-2.05	32.94	47.00	-14.06	-	-	QP



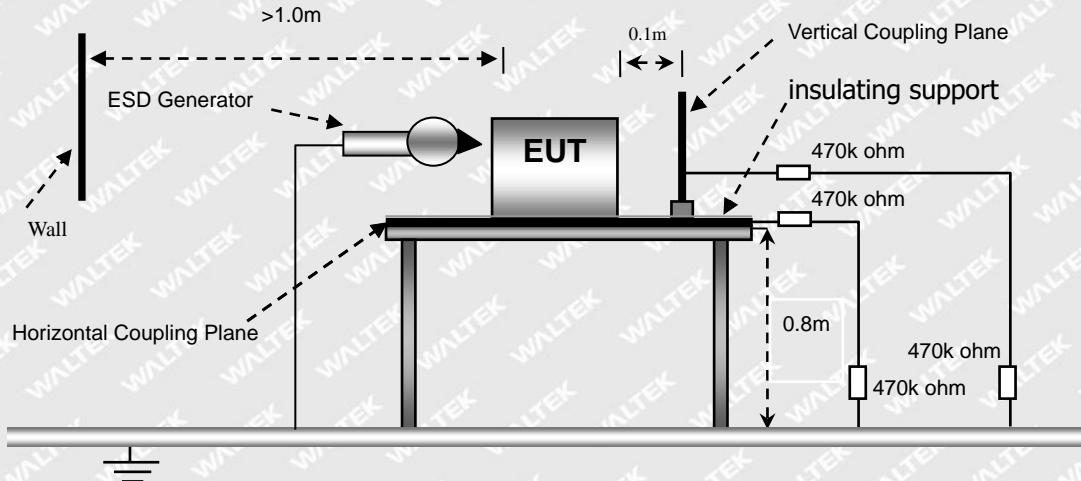
No.	Frequency (MHz)	Reading (dB <sub>uV/m</sub> )	Correct dB/m	Result (dB <sub>uV/m</sub> )	Limit (dB <sub>uV/m</sub> )	Margin (dB)	Degree ( )	Height (cm)	Remark
1	30.2111	31.43	-10.76	20.67	40.00	-19.33	-	-	QP
2	51.1209	28.53	-7.36	21.17	40.00	-18.83	-	-	QP
3	103.8055	27.04	-8.43	18.61	40.00	-21.39	-	-	QP
4	298.2681	26.88	-4.75	22.13	47.00	-24.87	-	-	QP
5	455.9058	34.25	-2.05	32.20	47.00	-14.80	-	-	QP
6	744.8661	28.31	3.81	32.12	47.00	-14.88	-	-	QP

Remark: '-'Means' the test Degree and Height are not recorded by the test software and only show the worst case in the test report.



## 4. Electrostatic Discharge (ESD)

### 4.1 Test Setup Block Diagram



### 4.2 Test Performance

Required Performance Criterion:	B
Mode:	TM1-TM2
Note: TM2 for TT,TR	

### 4.3 Environmental Conditions

Temperature:	26°C
Relative Humidity:	55%
ATM Pressure:	1011 mbar

### 4.4 Electrostatic Discharge Immunity Test Data

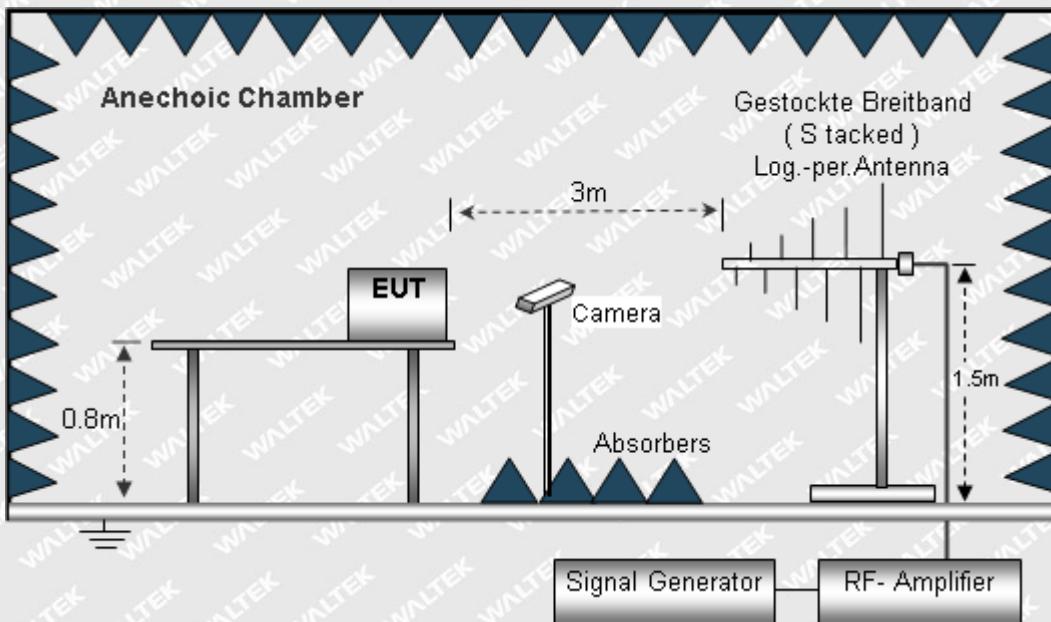


Test mode	TM1-TM2							
Test Points	Test Levels (kV)							
	-2	+2	-4	+4	-6	+6	-8	+8
Air Discharge								
USB Port	A	A	A	A	A	A	A	A
Enclosure	A	A	A	A	A	A	A	A
Direct Contact Discharge								
/	/	/	/	/	/	/	/	/
Indirect Contact Discharge								
HCP (6 Sides)	A	A	A	A	/	/	/	/
VCP (4 Sides)	A	A	A	A	/	/	/	/

Test Result: Pass

## 5. Radio Frequency Electromagnetic Field (R/S)

### 5.1 Test Setup Block Diagram



### 5.2 Test Performance

Required Performance Criterion:	A
Mode:	TM1-TM2
Note: TM2 for CT,CR	

### 5.3 Environmental Conditions

Temperature:	25°C
Relative Humidity:	52%
ATM Pressure:	1010 mbar

### 5.4 Continuous Radiated Disturbances Test Data

Frequency step: 1% of fundamental

Dwell time: 1 second

Modulation: AM by 1kHz sine wave with 80% modulation depth



Test mode		TM1-TM2							
Frequency Range(MHz)	Field (V/m)	Front		Rear		Left Side		Right Side	
		VERT	HORI	VERT	HORI	VERT	HORI	VERT	HORI
80-1000	3	A	A	A	A	A	A	A	A
1000-3000	3	A	A	A	A	A	A	A	A
3000-6000	3	A	A	A	A	A	A	A	A

Test Result: Pass

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## EXHIBIT 1 - EUT PHOTOGRAPHS

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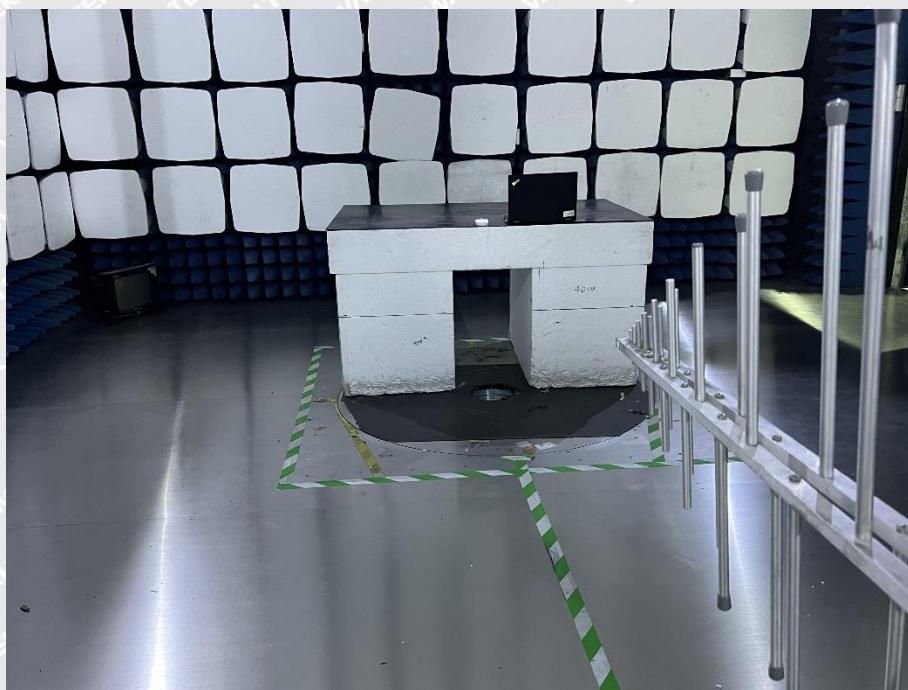
Please refer to "ANNEX".

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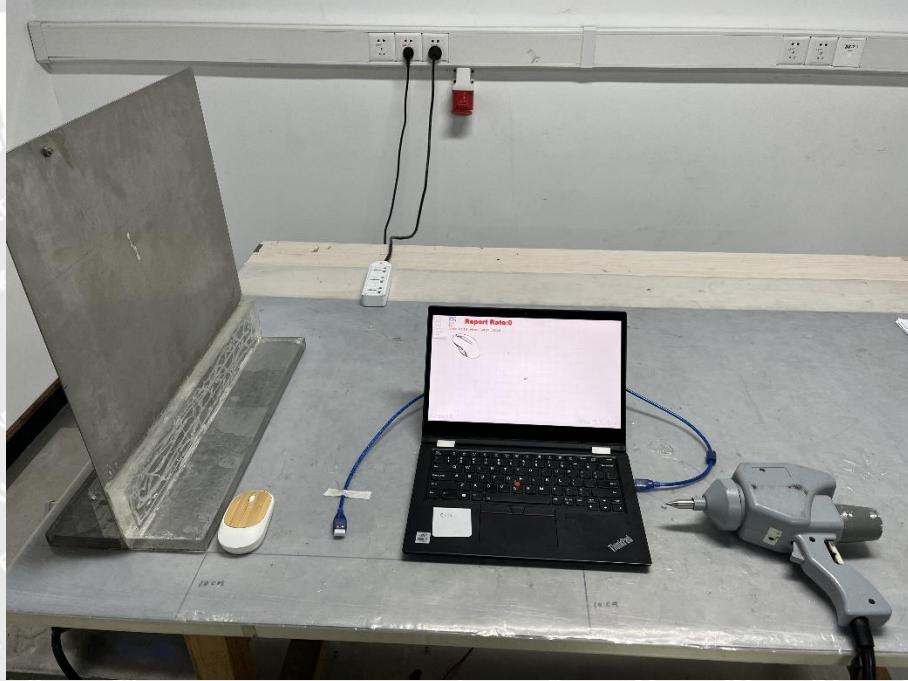


## EXHIBIT 2 - TEST SETUP PHOTOGRAPHS

Radiation Emission  
Test View(30MHz to  
1GHz)

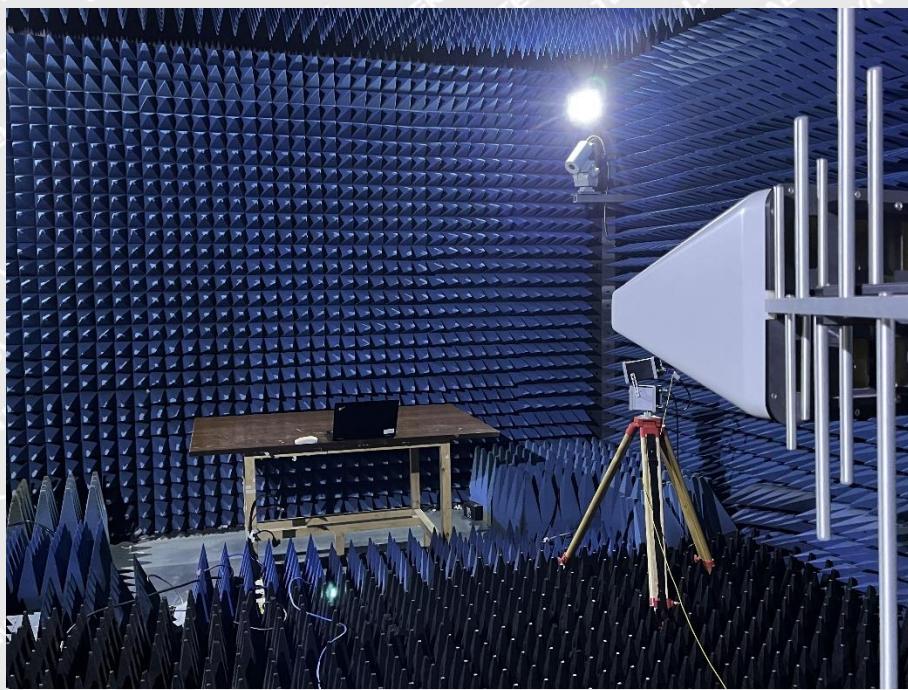


ESD Test View





**EN 61000-4-3 Test View**



\*\*\*\*\* END OF REPORT \*\*\*\*\*

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CNAS L4062



# TEST REPORT

**Reference No.** : WTF23X05108861W003  
**Manufacturer** : Mid Ocean Brands B.V.  
**Address** : 7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong  
**Factory** : 106613  
**Product Name** : Optical mouse in RABS bamboo  
**Model No.** : MO2085  
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EN IEC 61000-3-2:2019+A1:2021; EN 61000-3-3:2013+A2:2021  
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**Test Result** : Pass

**Remarks:**

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

**Prepared By:**

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## Report version

Version No.	Date of issue	Description
Rev.00	2023-06-02	Original
/	/	/

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## 1. GENERAL INFORMATION

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### 1.1 Product Description for Equipment Under Test (EUT)

<b>General Description of EUT</b>	
Product Name:	Optical mouse in RABS bamboo
Trade Name:	/
Model No.:	MO2085
Adding Model(s):	/
Rated Voltage:	DC5V
Battery Capacity:	/
Power Adaptor Model:	V05
Software Version:	V7.0

*Note: The test data is gathered from a production sample, provided by the manufacturer.*

<b>Technical Characteristics of EUT</b>	
<b>2.4GHz</b>	
Frequency Range:	2402-2480MHz
RF Output Power:	-7.96dBm (EIRP)
Type of Modulation:	GFSK
Type of Antenna:	PCB Antenna
Antenna Gain:	-5.92dBi

*Note: The Antenna Gain is provided by the customer and can affect the validity of results.*



## 1.2 Test Standards

The tests were performed according to following standards:

**EN 55032:2015+A1:2020:** Electromagnetic compatibility of multimedia equipment - Emission requirements

**EN 55035:2017+A11:2020:** Electromagnetic compatibility of multimedia equipment - Immunity requirements.

**EN IEC 61000-3-2:2019+A1:2021:** Electromagnetic compatibility (EMC) -- Part 3-2: Limits - Limits for harmonic current emissions (equipment input current up to and including 16 A per phase).

**EN 61000-3-3:2013+A2:2021:** Electromagnetic compatibility (EMC) -- Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current <= 16 A per phase and not subject to conditional connection.

**ETSI EN 301 489-1 V2.2.3 (2019-11):** Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard for Electromagnetic Compatibility.

**Draft ETSI EN 301 489-3 V2.3.0 (2022-07):** Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 3: Specific conditions for Short-Range Devices (SRD) operating on frequencies between 9 kHz and 246 GHz; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU.

**Maintenance of compliance** is the responsibility of the manufacturer. Any modification of the product maybe which result in lowering the emission/immunity should be checked to ensure compliance has been maintained.

## 1.3 Test Methodology

All measurements contained in this report were conducted with the standard ETSI EN 301489-1, Electromagnetic compatibility and Radio spectrum Matters (ERM); Electromagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements.



## 1.4 Test Facility

### Address of the test laboratory

Laboratory: Waltek Testing Group (Shenzhen) Co., Ltd.

Address: 1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd Road, Block 70 Bao'an District, Shenzhen, Guangdong, China

### FCC – Registration No.: 125990

Waltek Testing Group (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. The Designation Number is CN5010, and Test Firm Registration Number is 125990.

### Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Waltek Testing Group (Shenzhen) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

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## 1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission/immunity level. The test modes were adapted according to the operation manual for use, more detailed description as follows:

<b>Test Mode List</b>			
Test Mode	Description	Remark	
TM1	Normal working	The dongle connected to the notebook ; and normal working	
TM2	2.4GHz	TR, CR, TT, CT for EMS testing	

<b>Special Cable List and Details</b>			
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite
/	/	/	/

<b>Auxiliary Equipment List and Details</b>			
Description	Manufacturer	Model	Serial Number
Computer	/	L13 Yoga	/
USB dongle	/	MO2085	/



## 1.6 Performance Criteria for EMS

- EN 301 489-3, The performance criteria are:

In the table below:

- performance criterion A applies for immunity tests with phenomena of a continuous nature;
- performance criterion B applies for immunity tests with phenomena of a transient nature.

NOTE: Whether a phenomenon is considered transient, continuous or otherwise is indicated in the test procedures for the phenomenon in ETSI EN 301 489-1 [1], clause 9.

Table 2: Performance Requirements

Criterion	During test	After test
A	Operate as intended No loss of function No unintentional responses	Operate as intended No loss of function No degradation of performance No loss of stored data or user programmable functions
B	May show loss of function No unintentional responses	Operate as intended Lost function(s) shall be self-recoverable No degradation of performance No loss of stored data or user programmable functions

Where "operate as intended" or "no loss of function" is specified, the EUT shall demonstrate correct functioning as described in ETSI EN 301 489-3 [1], clause 5.

Where the EUT has more than one mode of operation (see clause 4.5.2), an unplanned transition from one mode to another is considered as an unintentional response. The EUT shall be tested in sufficient modes to confirm there are no such unintentional responses.



➤ **EN 55035, The performance criteria are:**

- A. The apparatus shall continue to operate as intended during and after the test. The manufacturer specifies some minimum performance level. The performance level may be specified by the manufacturer as a permissible loss of performance.
- B. The apparatus shall continue to operate as intended after the test. This indicates that the EUT does not need to function at normal performance levels during the test, but must recover. Again some minimal performance is defined by the manufacturer. No change in operating state or loss or data is permitted.
- C. Temporary loss of function is allowed. Operation of the EUT may stop as long as it is either automatically reset or can be manually restored by operation of the controls.

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## 1.7 Measurement Uncertainty

<b>Measurement uncertainty</b>	
<b>Parameter</b>	<b>Uncertainty</b>
Uncertainty for Radiated Emission in 3m chamber	@ 30-200MHz $\pm 4.52\text{dB}$ @ 0.2-1GHz $\pm 5.56\text{dB}$ @ 1-6GHz $\pm 3.84\text{dB}$ @ 6-18GHz $\pm 3.92\text{dB}$
Uncertainty for Conducted Emission	@ 9-150kHz $\pm 3.74\text{dB}$ @ 0.15-30MHz $\pm 3.34\text{dB}$
Uncertainty for Harmonic test	3.26%
Uncertainty for Flicker test	4.76%
Uncertainty for RS test	21%, k=2
Uncertainty for CS test	29%, k=2
Uncertainty for ESD test	The immunity measurement system uncertainty is within standard requirement and is based on a standard uncertainty multiplied by a coverage factor k=2, providing a level of confidence of approximately 95%.
Uncertainty for EFT test	
Uncertainty for Surges test	
Uncertainty for Voltage Dips, Voltage Variations and Short Interruptions Test	
Uncertainty for PFMF test	



## 1.8 Test Equipment List and Details

Description	Manufacturer	Model	Serial Number	Cal Date	Due Date
<input checked="" type="checkbox"/> Chamber A: Below 1GHz					
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2023-02-25	2024-02-24
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2023-02-25	2024-02-24
Amplifier	HP	8447F	2805A03475	2023-02-25	2024-02-24
Loop Antenna	Schwarz beck	FMZB 1516	9773	2021-03-20	2024-03-19
Trilog Broadband Antenna	Schwarz beck	VULB9163	9163-333	2023-03-20	2026-03-19
<input checked="" type="checkbox"/> Chamber A: Above 1GHz					
Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2023-02-25	2024-02-24
Spectrum Analyzer	Rohde & Schwarz	FSP40	100612	2023-02-25	2024-02-24
EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2023-02-25	2024-02-24
Amplifier	C&D	PAP-1G18	14918	2023-02-25	2024-02-24
Horn Antenna	ETS	3117	00086197	2021-03-19	2024-03-18
DRG Horn Antenna	A.H. SYSTEMS	SAS-574	571	2021-03-19	2024-03-18
Pre-amplifier	Schwarz beck	BBV 9721	9721-031	2023-02-25	2024-02-24
<input type="checkbox"/> Chamber B:Below 1GHz					
Trilog Broadband Antenna	Schwarz beck	VULB9163(B)	9163-635	2021-04-09	2024-04-08
Amplifier	Agilent	8447D	2944A10179	2023-02-25	2024-02-24
EMI Test Receiver	Rohde & Schwarz	ESPI	101391	2023-02-25	2024-02-24
<input type="checkbox"/> Chamber C:Below 1GHz					
EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2023-02-25	2024-02-24
Trilog Broadband Antenna	Schwarz beck	VULB 9168	1194	2021-05-28	2024-05-27
Amplifier	HP	8447F	2944A03869	2023-02-25	2024-02-24
<input type="checkbox"/> Chamber C: Above 1GHz					
EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2023-02-25	2024-02-24
Horn Antenna	POAM	RTF-11A	LP228060221	2023-03-10	2026-03-09
Amplifier	Tonscend	TAP01018050	AP22E806235	2023-02-25	2024-02-24
<input checked="" type="checkbox"/> Conducted Room 1#					
EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2023-02-25	2024-02-24
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2023-02-25	2024-02-24
AC LISN	Schwarz beck	NSLK8126	8126-224	2023-02-25	2024-02-24
8-WIRE LISN	Schwarz beck	8158	CAT3-8158-0059	2023-02-25	2024-02-24
8-WIRE LISN	Schwarz beck	8158	CAT5-8158-0117	2023-02-25	2024-02-24
<input type="checkbox"/> Conducted Room 2#					
EMI Test Receiver	Rohde & Schwarz	ESPI	10129	2023-02-25	2024-02-24
LISN	Rohde & Schwarz	ENV 216	100097	2023-02-25	2024-02-24



EMF					
VDH Test Head	AFJ	VDH 30	SC022Z	2023-02-25	2024-02-24
3 Loop Antenna					
Loop Antenna	ZHINAN	ZN30401	19037	2023-02-25	2025-02-24
Clamp					
Clamp	Luthi	MDS21	3809	2023-02-27	2024-02-26
PFMF					
PMF Generator	LIONCEL	PMF-801C-C	0171101	2023-02-25	2024-02-24
PMF Antenna	LIONCEL	PMF-801C-A	0180302	2023-02-25	2024-02-24
Instantaneous PMF Generator Module	LIONCEL	PMF-801C-T	0171001	2023-02-25	2024-02-24
H/F					
Digital Power Analyzer	California Instrument	CTS	72831	2023-02-25	2024-02-24
Power Source	California Instrument	5001IX-CTS-400	25965	2023-02-25	2024-02-24
ESD					
ESD Generator	LIONCEL	ESD-203B	0170901	2023-03-14	2024-03-13
EFT/SURGE/DIPS					
Transient 2000	EMC PARTNER	TRA2000	863	2023-02-25	2024-02-24
Couple Clamp	EMC PARTNER	CN-EFT1000	513	2023-02-25	2024-02-24
CS					
CONDUCTED IMMUNITY TEST SYSTEM	FRANKONIA	CIT-10/75	126B1247/2013	2023-02-25	2024-02-24
Attenuator	EMTEST	MA-5100/6BF2	1009	2023-02-25	2024-02-24
CDN	Luthi	L-801M2/M3	2665	2023-02-25	2024-02-24
CDN	LIONCEL	CDN-T8	0210401	2023-02-25	2024-02-24
EM Clamp	TESEQ	KEMZ801A	45028	2023-02-25	2024-02-24
RS					
Signal Generator	HP	8688B	3438A00604	2023-02-25	2024-02-24
Power Meter	KEITHLEY	3500	1162591	2023-02-25	2024-02-24
Power Meter	KEITHLEY	3500	1121428	2023-02-25	2024-02-24
RF Power Amplifier	MicoTop	MPA-80-1000-250	MPA1906239	2023-02-25	2024-02-24
RF Power Amplifier	MicoTop	MPA-80-6000-100	MPA1906238	2023-02-25	2024-02-24
Antenna	SCHWARZBECK	STLP 9129	9129 114	N/A	N/A
Power Meter	Agilent	E4419B	GB42420578	2023-02-25	2024-02-24



<b>Software List</b>			
Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)*	Farad	EZ-EMC	RA-03A1
EMI Test Software (Conducted Emission)*	Farad	EZ-EMC	RA-03A1

\*Remark: indicates software version used in the compliance certification testing.

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## 2. SUMMARY OF TEST RESULTS

Standards	Reference	Description of Test Item	Result
ETSI EN 301 489-1	8.2	Radiated Emissions	Pass
	8.3	Conducted Emissions for DC Power Port	N/A
	8.4	Conducted Emissions for AC Power Port	N/A
	8.5	Harmonic Current Emissions	N/A
	8.6	Voltage Fluctuations and Flicker	N/A
	8.7	Telecommunication Ports	N/A
	9.2	Radio Frequency Electromagnetic Field	Pass
	9.3	Electrostatic Discharge	Pass
	9.4	Fast Transients, Common Mode	N/A
	9.5	Radio Frequency, Common Mode	N/A
	9.6	Transient and Surges in the Vehicular Environment	N/A
	9.7	Voltage Dips and Interruptions	N/A
	9.8	Surges	N/A

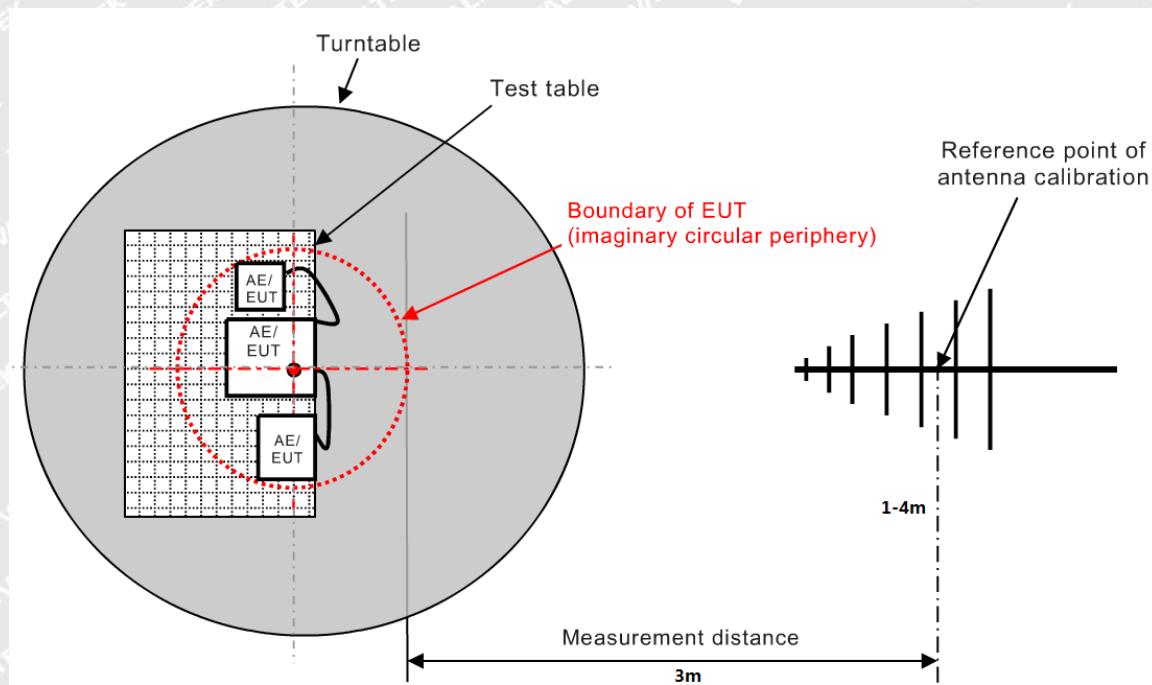
Pass: The EUT complies with the essential requirements in the standard.  
Fail: The EUT does not comply with the essential requirements in the standard.  
N/A: Not applicable.



### 3. Radiated Emissions

#### 3.2 Test Procedure

Test is conducting under the description of EN55032 Information technology equipment - Radio disturbance characteristics - Limits and methods of measurement.



#### 3.2 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The “Margin” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of  $-6\text{dB}\mu\text{V}$  means the emission is  $6\text{dB}\mu\text{V}$  below the maximum limit for Class B device. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{EN 301489 Class B Limit}$$



### 3.3 Environmental Conditions

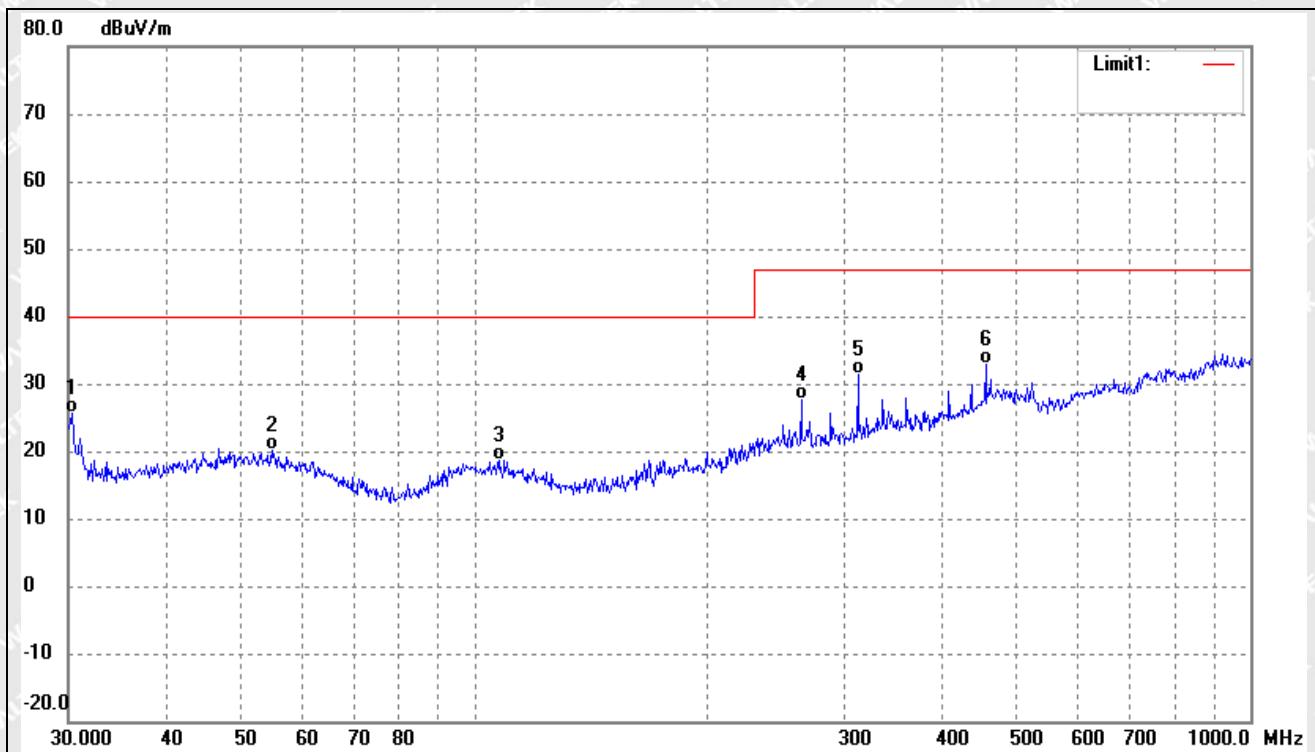
Temperature:	22° C
Relative Humidity:	54%
ATM Pressure:	1011 mbar

### 3.4 Summary of Test Results/Plots

Note: Only show the worst case in the test report

➤ 30MHz to 1GHz

Test mode:	TM1	Polarity:	Horizontal
------------	-----	-----------	------------



No.	Frequency (MHz)	Reading (dBuV/m)	Correct dB/m	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ( )	Height (cm)	Remark
1	30.3173	36.33	-10.76	25.57	40.00	-14.43	-	-	QP
2	54.8348	27.66	-7.61	20.05	40.00	-19.95	-	-	QP
3	107.5101	27.28	-8.54	18.74	40.00	-21.26	-	-	QP
4	263.8190	33.97	-6.24	27.73	47.00	-19.27	-	-	QP
5	312.1794	36.00	-4.53	31.47	47.00	-15.53	-	-	QP
6	455.9058	34.99	-2.05	32.94	47.00	-14.06	-	-	QP

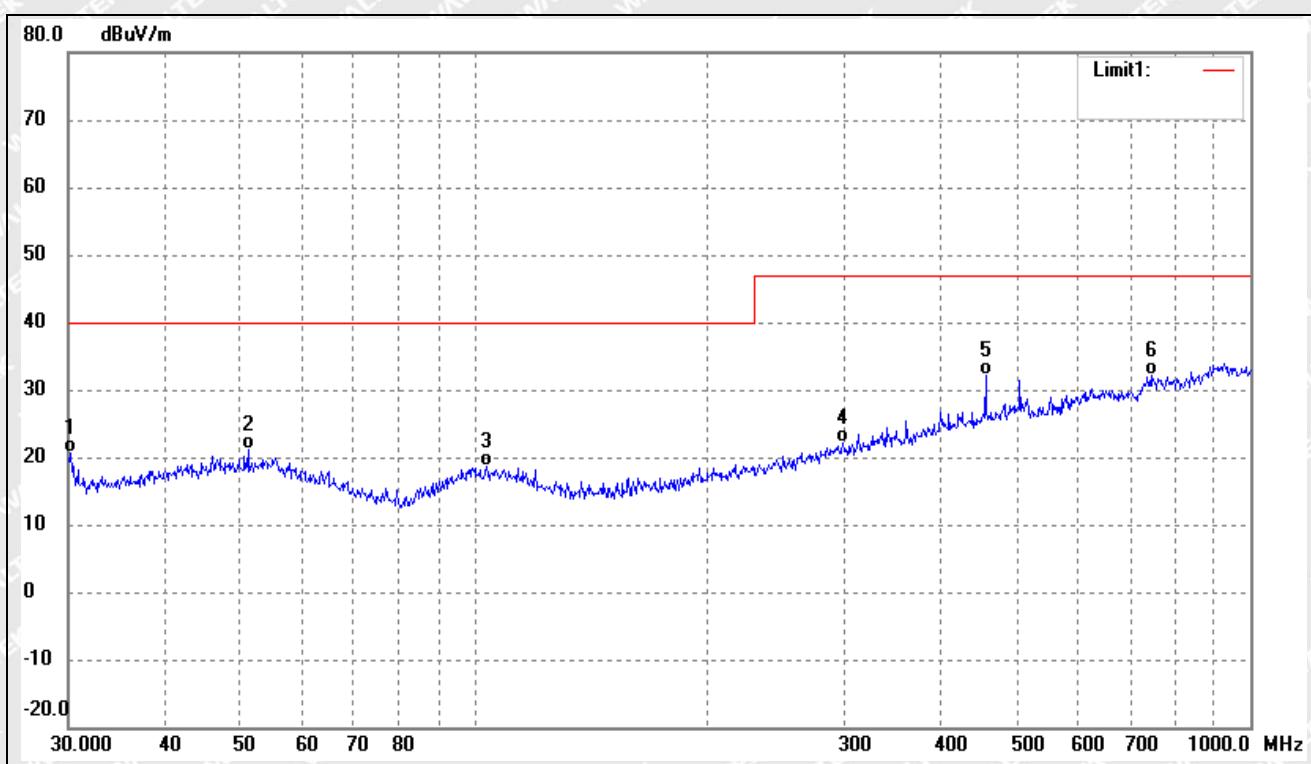


Test mode:

TM1

Polarity:

Vertical



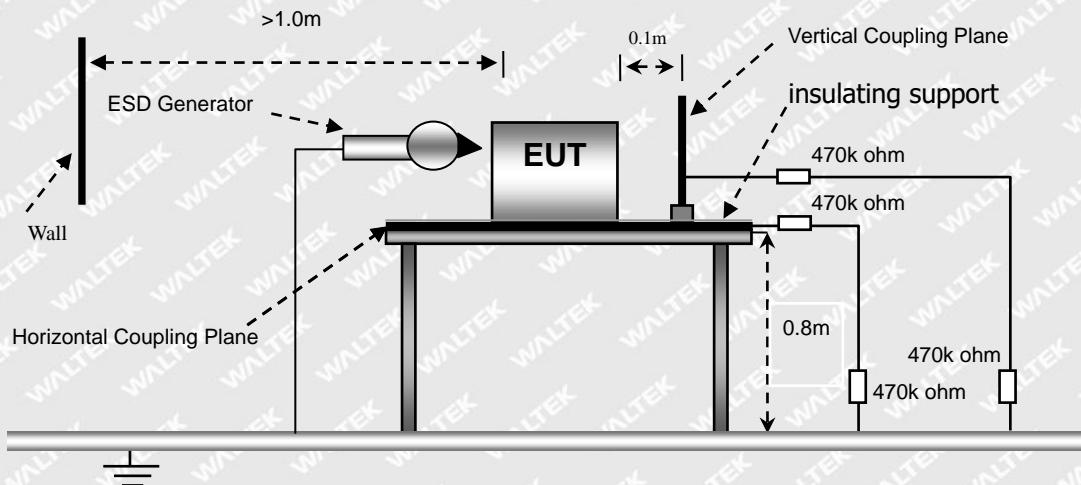
No.	Frequency (MHz)	Reading (dB $\mu$ V/m)	Correct dB/m	Result (dB $\mu$ V/m)	Limit (dB $\mu$ V/m)	Margin (dB)	Degree ( )	Height (cm)	Remark
1	30.2111	31.43	-10.76	20.67	40.00	-19.33	-	-	QP
2	51.1209	28.53	-7.36	21.17	40.00	-18.83	-	-	QP
3	103.8055	27.04	-8.43	18.61	40.00	-21.39	-	-	QP
4	298.2681	26.88	-4.75	22.13	47.00	-24.87	-	-	QP
5	455.9058	34.25	-2.05	32.20	47.00	-14.80	-	-	QP
6	744.8661	28.31	3.81	32.12	47.00	-14.88	-	-	QP

Remark: '-'Means' the test Degree and Height are not recorded by the test software and only show the worst case in the test report.



## 4. Electrostatic Discharge (ESD)

### 4.1 Test Setup Block Diagram



### 4.2 Test Performance

Required Performance Criterion:	B
Mode:	TM1-TM2
Note: TM2 for TT,TR	

### 4.3 Environmental Conditions

Temperature:	26°C
Relative Humidity:	55%
ATM Pressure:	1011 mbar

### 4.4 Electrostatic Discharge Immunity Test Data

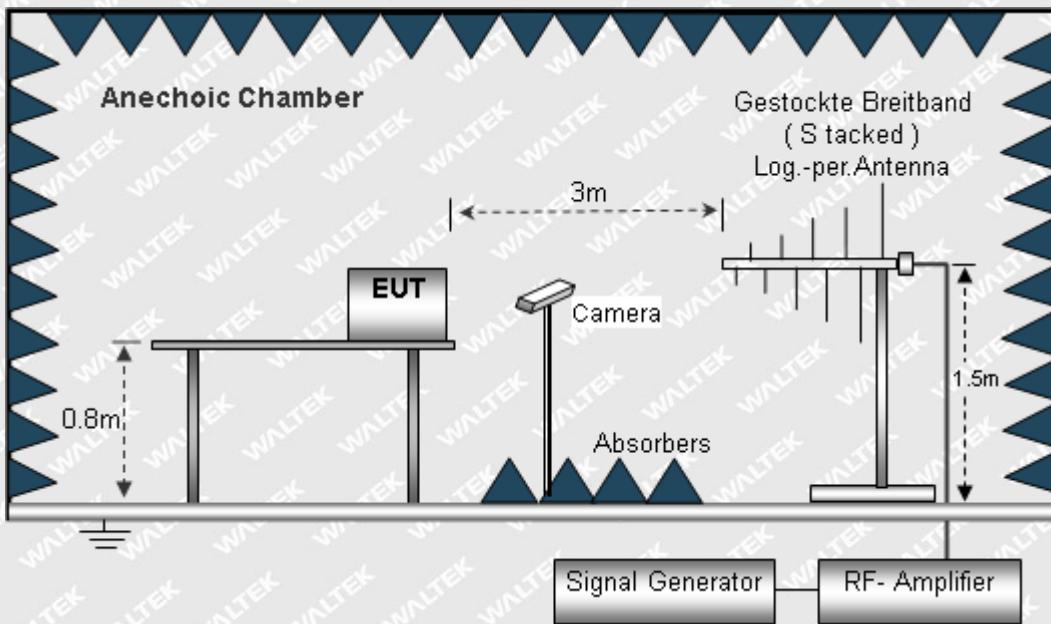


Test mode	TM1-TM2							
Test Points	Test Levels (kV)							
	-2	+2	-4	+4	-6	+6	-8	+8
Air Discharge								
USB Port	A	A	A	A	A	A	A	A
Enclosure	A	A	A	A	A	A	A	A
Direct Contact Discharge								
/	/	/	/	/	/	/	/	/
Indirect Contact Discharge								
HCP (6 Sides)	A	A	A	A	/	/	/	/
VCP (4 Sides)	A	A	A	A	/	/	/	/

Test Result: Pass

## 5. Radio Frequency Electromagnetic Field (R/S)

### 5.1 Test Setup Block Diagram



### 5.2 Test Performance

Required Performance Criterion:	A
Mode:	TM1-TM2
Note: TM2 for CT,CR	

### 5.3 Environmental Conditions

Temperature:	25°C
Relative Humidity:	52%
ATM Pressure:	1010 mbar

### 5.4 Continuous Radiated Disturbances Test Data

Frequency step: 1% of fundamental

Dwell time: 1 second

Modulation: AM by 1kHz sine wave with 80% modulation depth



Test mode		TM1-TM2							
Frequency Range(MHz)	Field (V/m)	Front		Rear		Left Side		Right Side	
		VERT	HORI	VERT	HORI	VERT	HORI	VERT	HORI
80-1000	3	A	A	A	A	A	A	A	A
1000-3000	3	A	A	A	A	A	A	A	A
3000-6000	3	A	A	A	A	A	A	A	A

Test Result: Pass

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## EXHIBIT 1 - EUT PHOTOGRAPHS

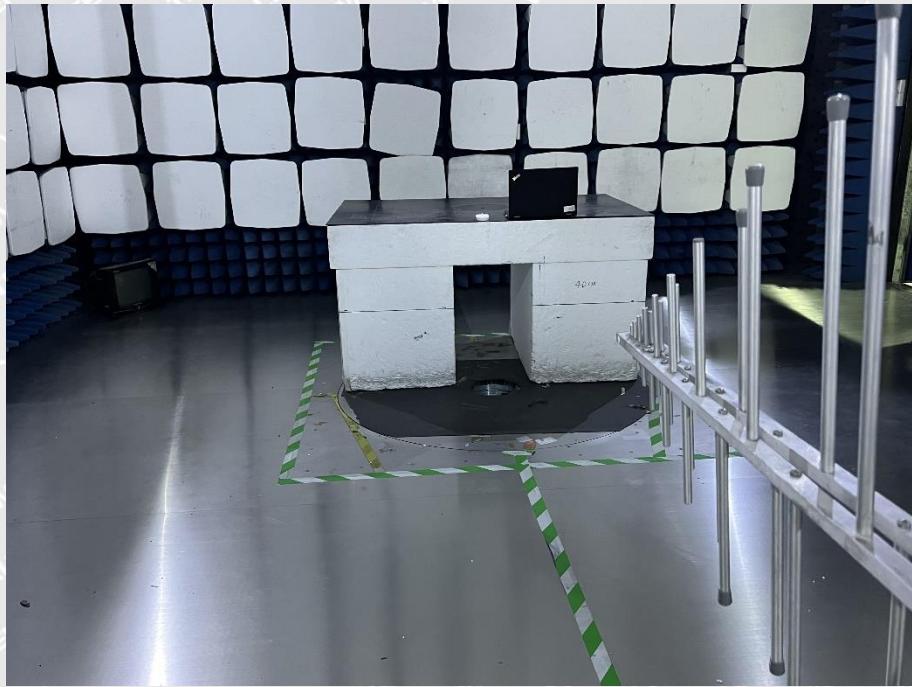
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Please refer to "ANNEX".

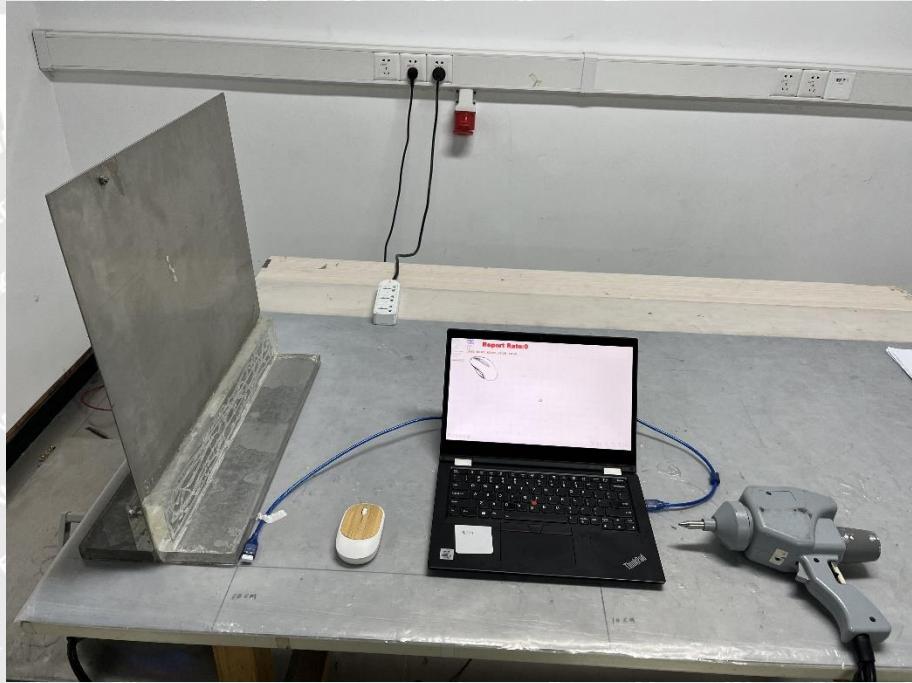
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## EXHIBIT 2 - TEST SETUP PHOTOGRAPHS

**Radiation Emission  
Test View(30MHz to  
1GHz)**

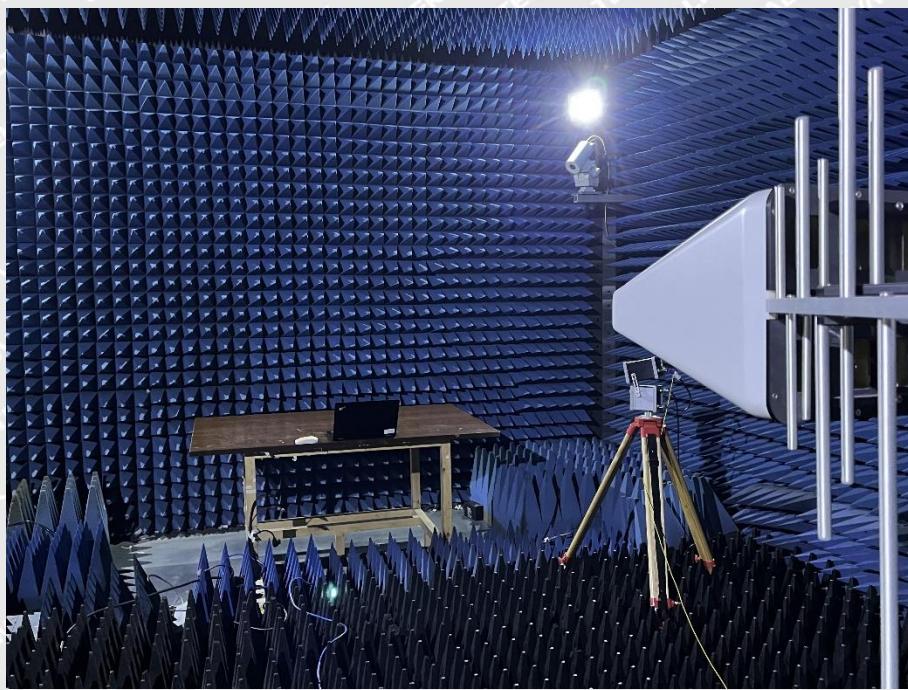


**ESD Test View**





**EN 61000-4-3 Test View**



\*\*\*\*\* END OF REPORT \*\*\*\*\*

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